

IRF6100

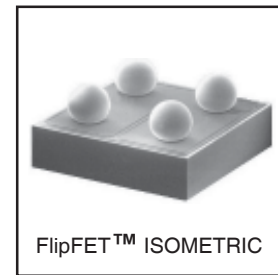
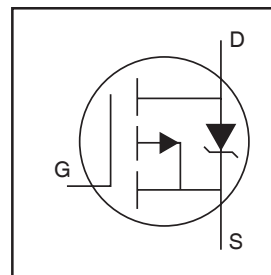
HEXFET[®] Power MOSFET

- Ultra Low $R_{DS(on)}$ per Footprint Area
- Low Thermal Resistance
- P-Channel MOSFET
- One-third Footprint of SOT-23
- Super Low Profile (<.8mm)
- Available Tested on Tape & Reel

V_{DSS}	$R_{DS(on)}$ max	I_D
-20V	0.065 Ω @ $V_{GS} = -4.5V$	-5.1A
	0.095 Ω @ $V_{GS} = -2.5V$	-4.1A

Description

True chip-scale packaging is available from International Rectifier. Through the use of advanced processing techniques, and a unique packaging concept, extremely low on-resistance and the highest power densities in the industry have been made available for battery and load management applications. These benefits, combined with the ruggedized device design, that International Rectifier is well known for, provides the designer with an extremely efficient and reliable device.



The FlipFET[™] package, is one-third the footprint of a comparable SOT-23 package and has a profile of less than .8mm. Combined with the low thermal resistance of the die level device, this makes the FlipFET[™] the best device for application where printed circuit board space is at a premium and in extremely thin application environments such as battery packs, cell phones and PCMCIA cards.

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain- Source Voltage	-20	V
I_D @ $T_A = 25^\circ C$	Continuous Drain Current, V_{GS} @ 4.5V	± 5.1	A
I_D @ $T_A = 70^\circ C$	Continuous Drain Current, V_{GS} @ 4.5V	± 3.5	
I_{DM}	Pulsed Drain Current ①	± 35	
P_D @ $T_A = 25^\circ C$	Power Dissipation ③	2.2	W
P_D @ $T_A = 70^\circ C$	Power Dissipation ③	1.4	
	Linear Derating Factor	17	mW/ $^\circ C$
V_{GS}	Gate-to-Source Voltage	± 12	V
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150	$^\circ C$

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③		56.5	$^\circ C/W$
$R_{\theta J-PCB}$	Junction-to-PCB mounted	35	—	

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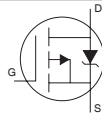
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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-20	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.010	—	V/°C	Reference to 25°C , $I_D = -1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.065	Ω	$V_{GS} = -4.5V, I_D = -5.1A$ ②
		—	—	0.095		$V_{GS} = -2.5V, I_D = -4.1A$ ②
$V_{GS(th)}$	Gate Threshold Voltage	-0.45	—	-1.2	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
g_{fs}	Forward Transconductance	9.8	—	—	S	$V_{DS} = -10V, I_D = -5.1A$
I_{DSS}	Drain-to-Source Leakage Current	—	—	-1.0	μA	$V_{DS} = -20V, V_{GS} = 0V$
		—	—	-25		$V_{DS} = -16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 12V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -12V$
Q_g	Total Gate Charge	—	14	21	nC	$I_D = -5.1A$
Q_{gs}	Gate-to-Source Charge	—	1.9	2.9		$V_{DS} = -16V$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	5.0	7.5		$V_{GS} = -5.0V$
$t_{d(on)}$	Turn-On Delay Time	—	12	—	ns	$V_{DD} = -10V$
t_r	Rise Time	—	12	—		$I_D = -1.0A$
$t_{d(off)}$	Turn-Off Delay Time	—	50	—		$R_G = 5.8\Omega$
t_f	Fall Time	—	50	—		$V_{GS} = -4.5V$ ②
C_{iss}	Input Capacitance	—	1230	—	pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance	—	250	—		$V_{DS} = -15V$
C_{rss}	Reverse Transfer Capacitance	—	180	—		$f = 1.0\text{MHz}$, See Fig. 5

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	-2.2	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-33		
V_{SD}	Diode Forward Voltage	—	—	-1.2	V	$T_J = 25^\circ\text{C}, I_S = -2.2A, V_{GS} = 0V$ ②
t_{rr}	Reverse Recovery Time	—	48	72	ns	$T_J = 25^\circ\text{C}, I_F = -2.2A$
Q_{rr}	Reverse Recovery Charge	—	34	51	nC	$di/dt = 100A/\mu s$ ②

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ③ When mounted on 1 inch square 2oz copper on FR-4.
- ② Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$.

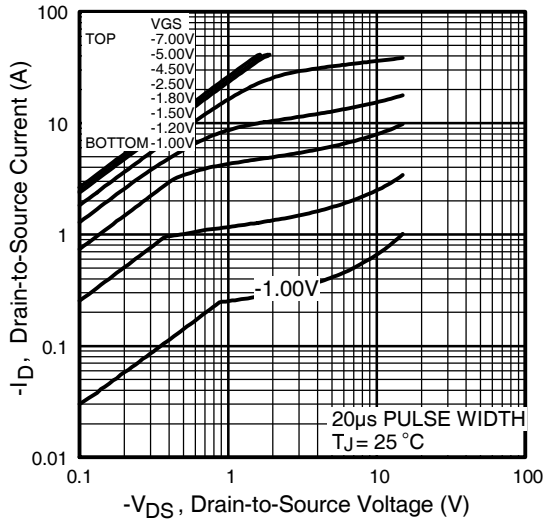


Fig 1. Typical Output Characteristics

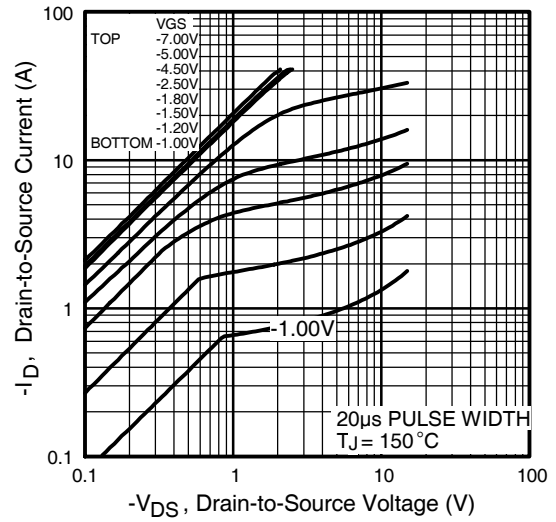


Fig 2. Typical Output Characteristics

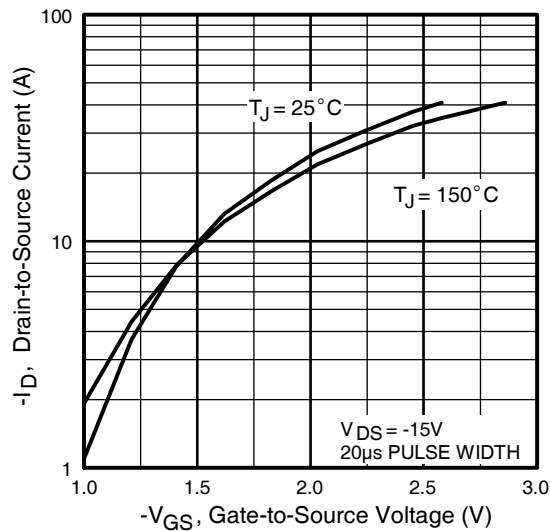


Fig 3. Typical Transfer Characteristics

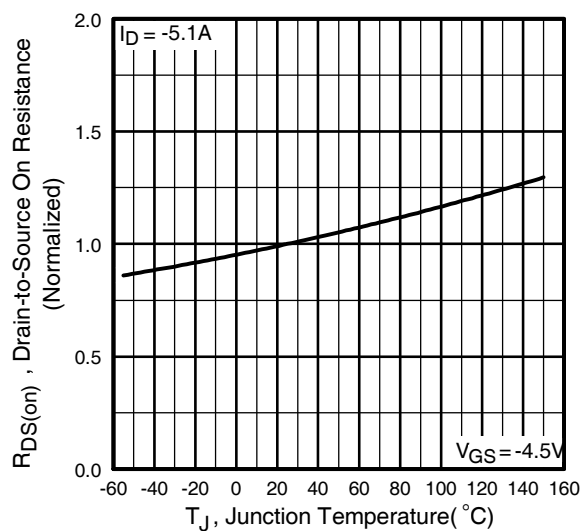


Fig 4. Normalized On-Resistance Vs. Temperature

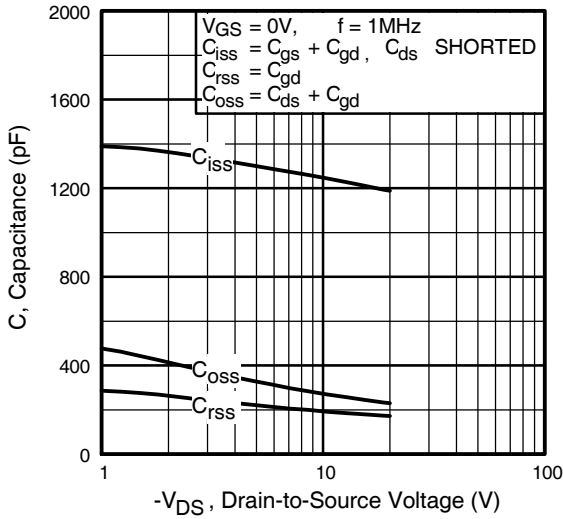


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

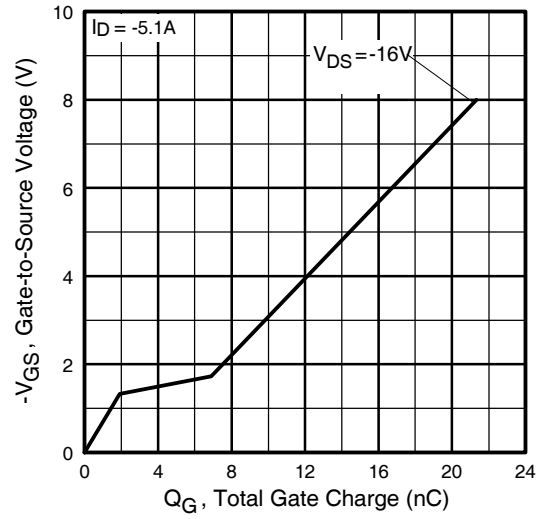


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

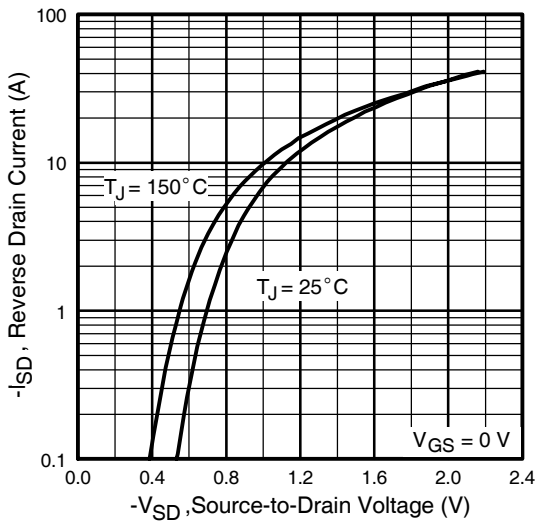


Fig 7. Typical Source-Drain Diode Forward Voltage

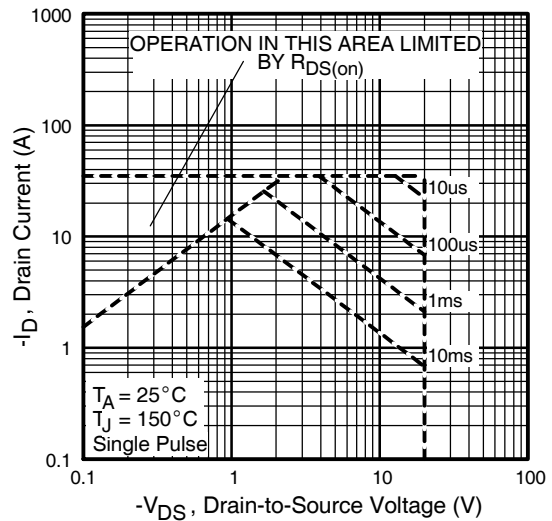


Fig 8. Maximum Safe Operating Area

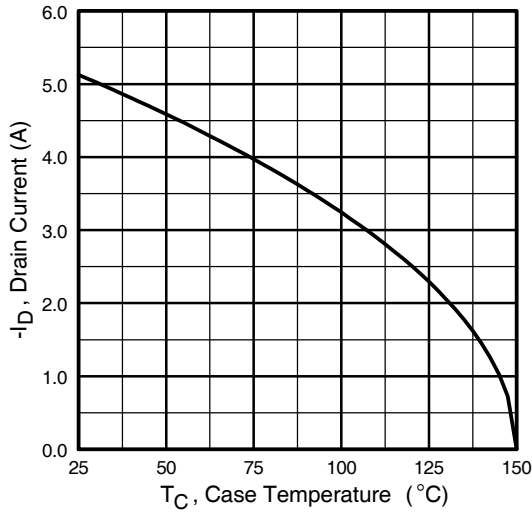


Fig 9. Maximum Drain Current Vs. Case Temperature

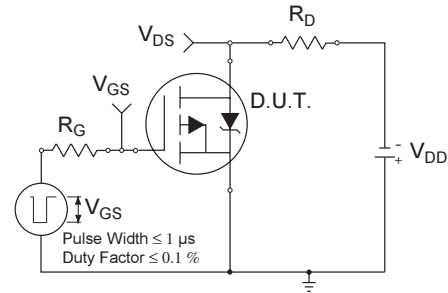


Fig 10a. Switching Time Test Circuit

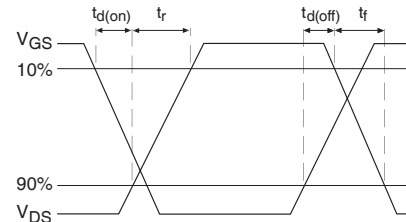


Fig 10b. Switching Time Waveforms

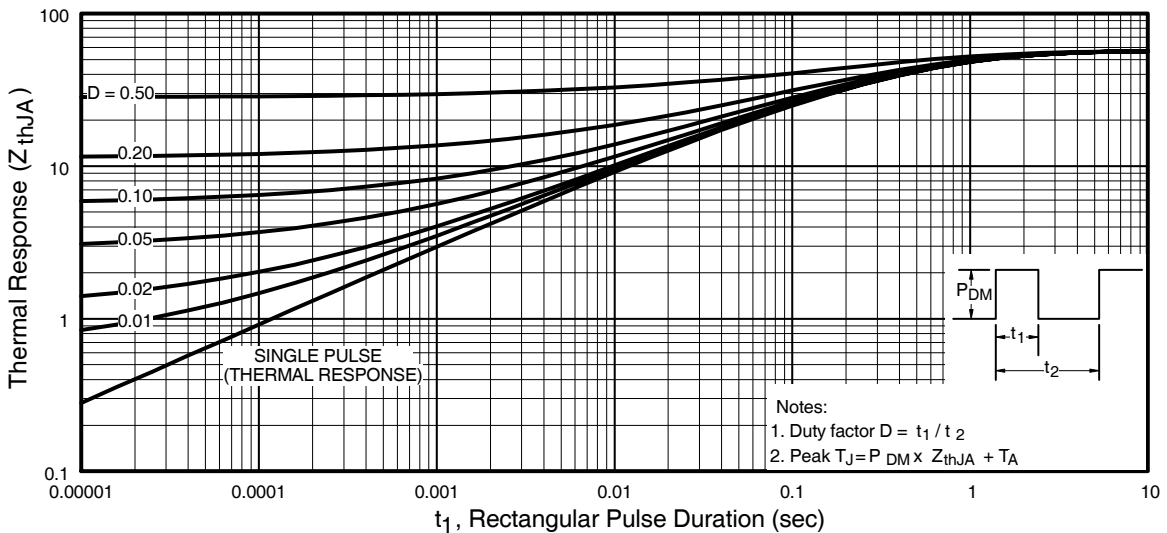


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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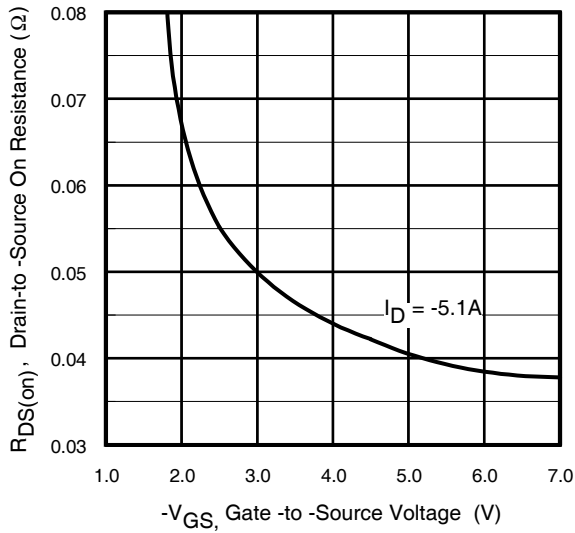


Fig 12. Typical On-Resistance Vs. Gate Voltage

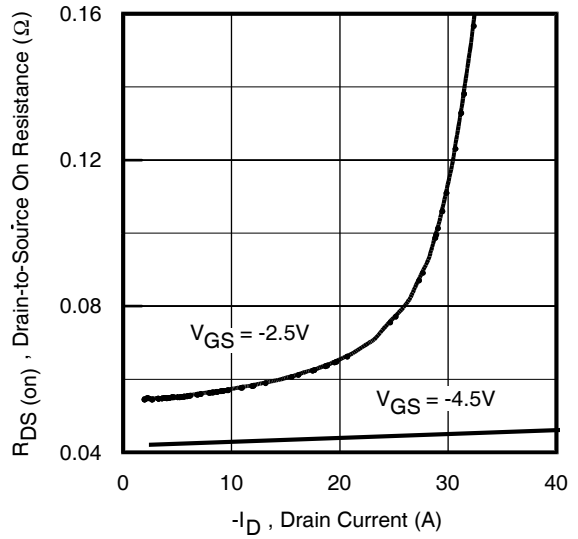


Fig 13. Typical On-Resistance Vs. Drain Current

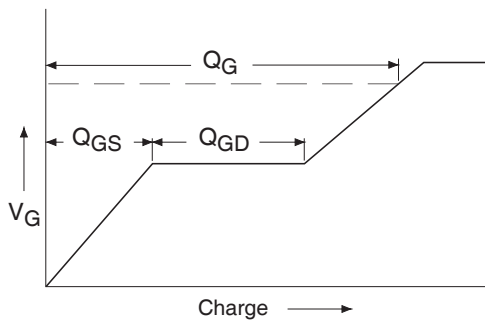


Fig 14a. Basic Gate Charge Waveform

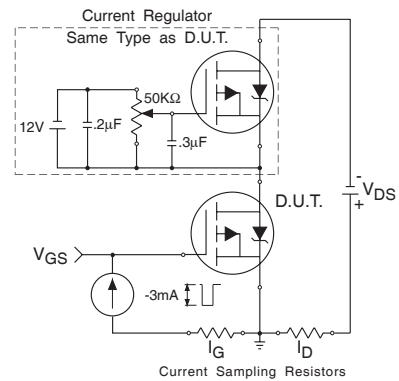


Fig 14b. Gate Charge Test Circuit

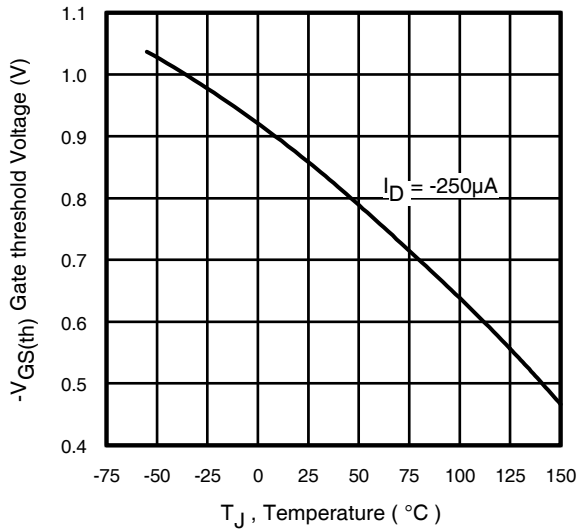


Fig 15. Threshold Voltage Vs. Temperature

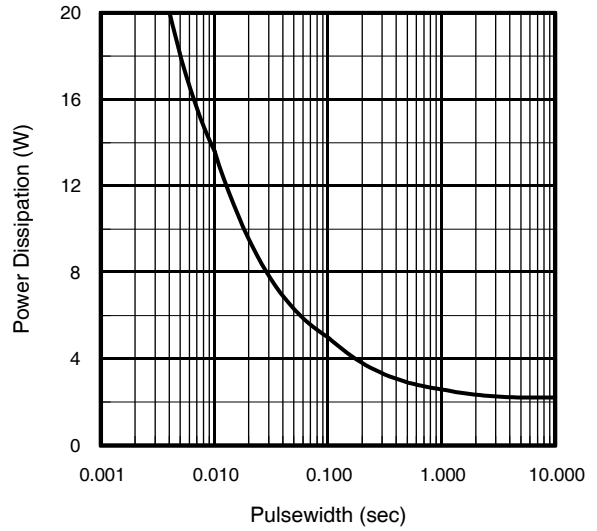
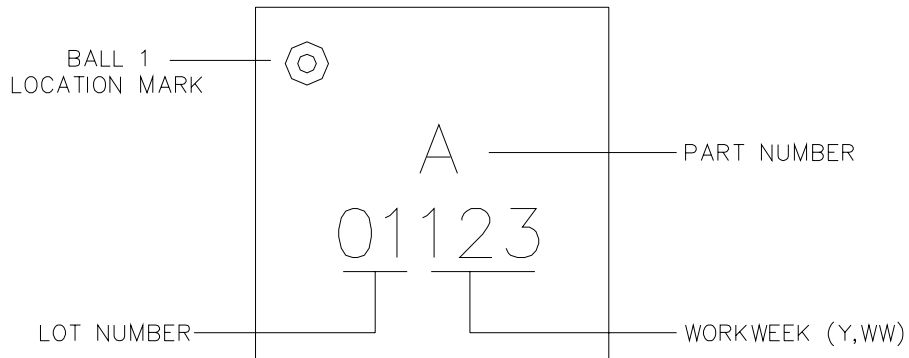


Fig 16. Maximum Power Dissipation Vs. Time

FlipFET™ Part Marking Information

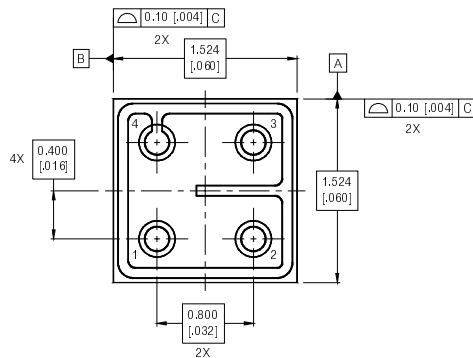


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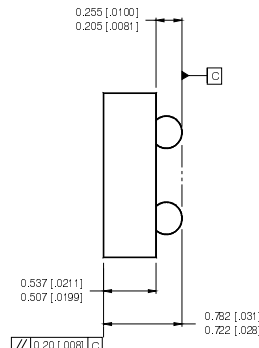
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FlipFET™ Outline Dimension and Tape and Reel

NOTES:
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].



BOTTOM VIEW



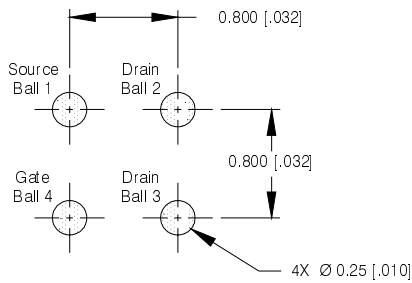
SIDE VIEW

BALL ASSIGNMENTS

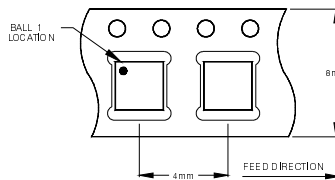
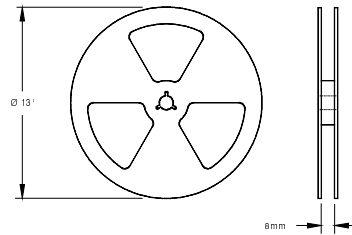
- 1 = SOURCE
- 2 = DRAIN
- 3 = DRAIN
- 4 = GATE

LEADFREE SOLDER BALL COMPOSITION

- 95.9% Sn
- 3.5% Ag
- 0.7% Cu



RECOMMENDED FOOTPRINT



NOTES:
1. TAPE AND REEL OUTLINE CONFORMS TO EIA-481 & EIA-541.

Tape and Reel

Data and specifications subject to change without notice.
This product has been designed and qualified for the Consumer market.
Qualification Standards can be found on IR's Web site.

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IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

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